

• Notes Set 13: Circuit noise analysis: overview and “benchmarks”

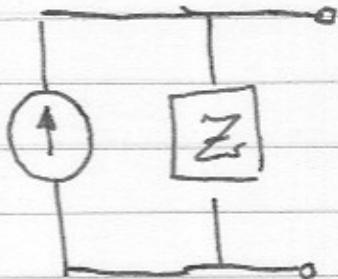
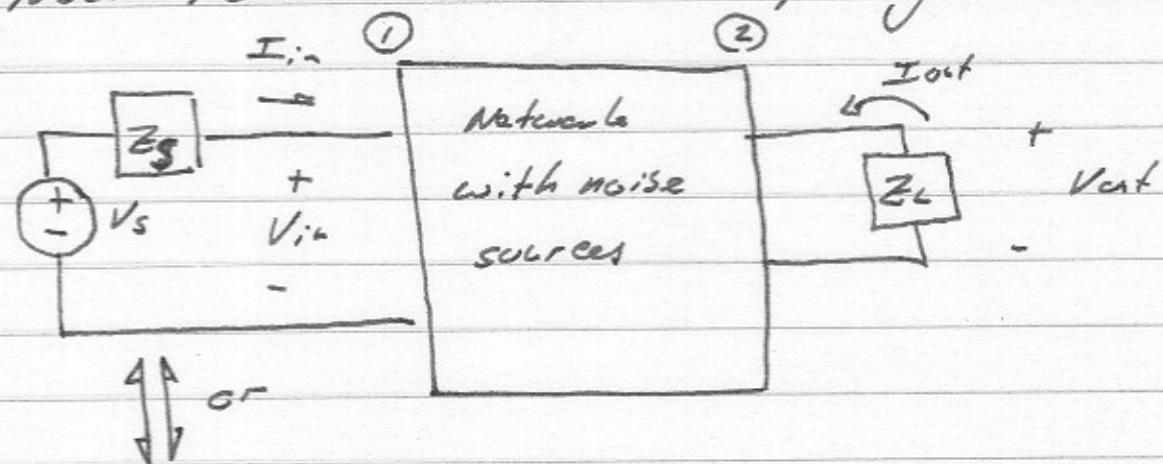
- Recap of notes set 6: 2-port noise models, etc.
- circuit noise analysis. Total input referred noise voltage, total input referred noise current.
- Short circuit input noise voltage. Open circuit input noise current
- Noise figure, minimum noise figure and optimum source impedance.
- signal-noise analysis by different communities: voltage method, current method, power method, temperature method, and equivalence of all of these.
- appropriateness of each method to various circuit/system problems

Now we come to circuit noise analysis. Here the style of the material is quite different:

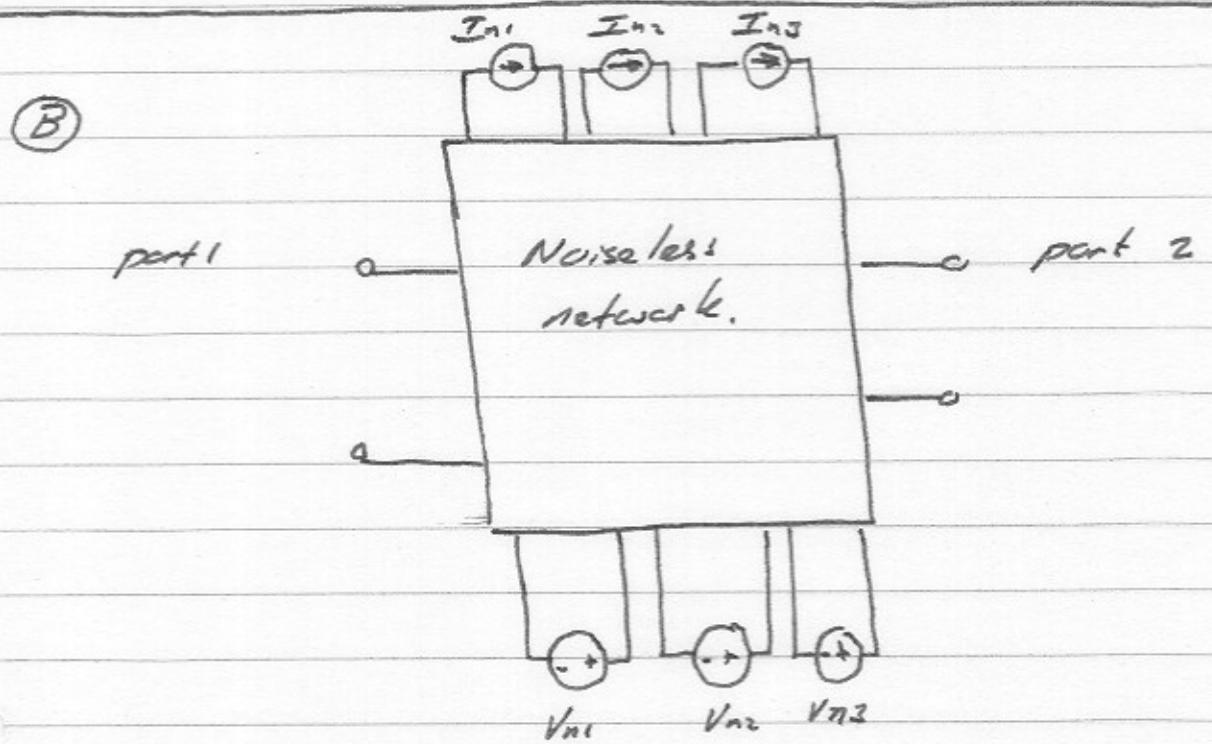
There are far fewer new ideas in this section. There is however a great deal to learn on how to work such problems effectively and efficiently. Basically, there are no new relationships to learn; we just need to know how to solve problems.

2

Now remember relationships given earlier:

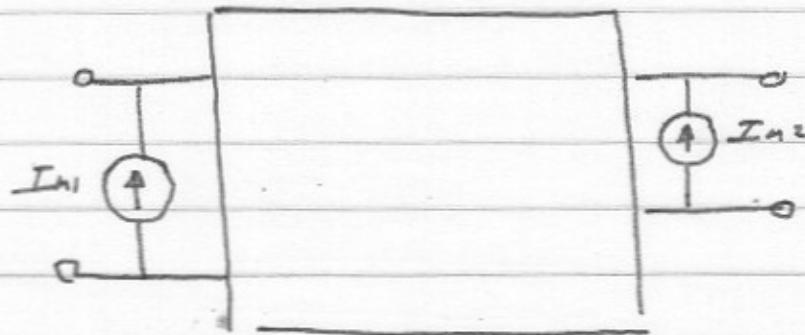


Z_L & Z_s also may
generate noise.



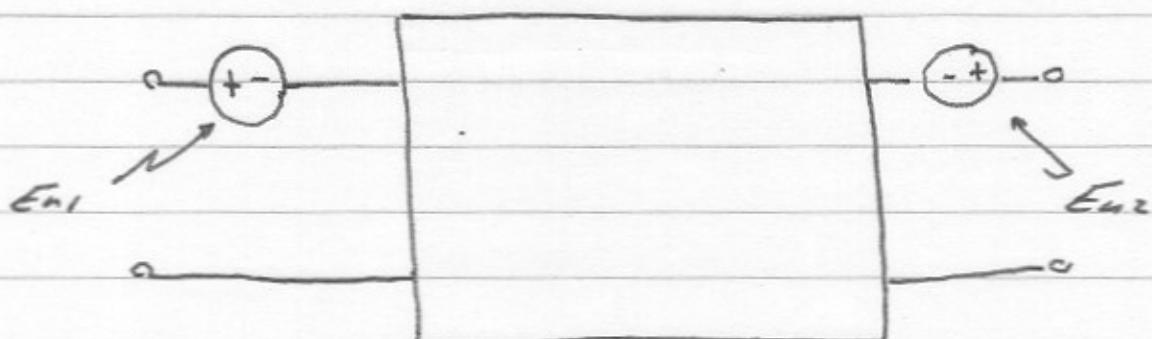
(3)

(c) In principle we then solve for the effect of the many noise generators to find



↑ or ↓

Note:
These are
measurable

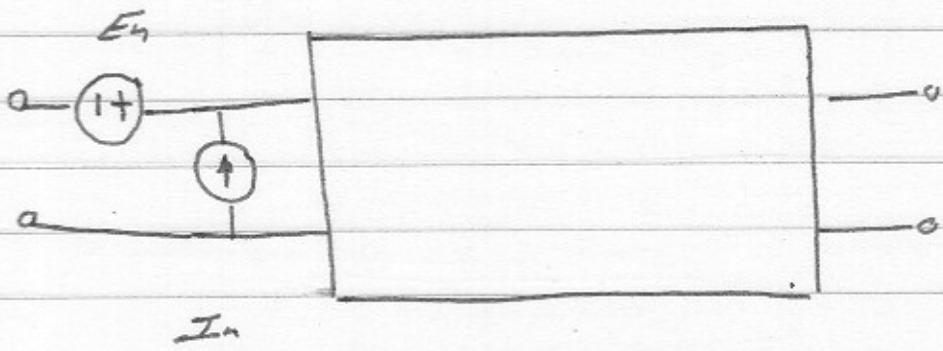


where $(E_{n1}, E_{n2}) / (I_{n1}, I_{n2})$ are the open circuit/ short circuit noise voltages/ currents at the 2 ports. They are correlated.

(4)

D one then transforms these to

the far more useful E_n - I_n model



I_n and E_n are:

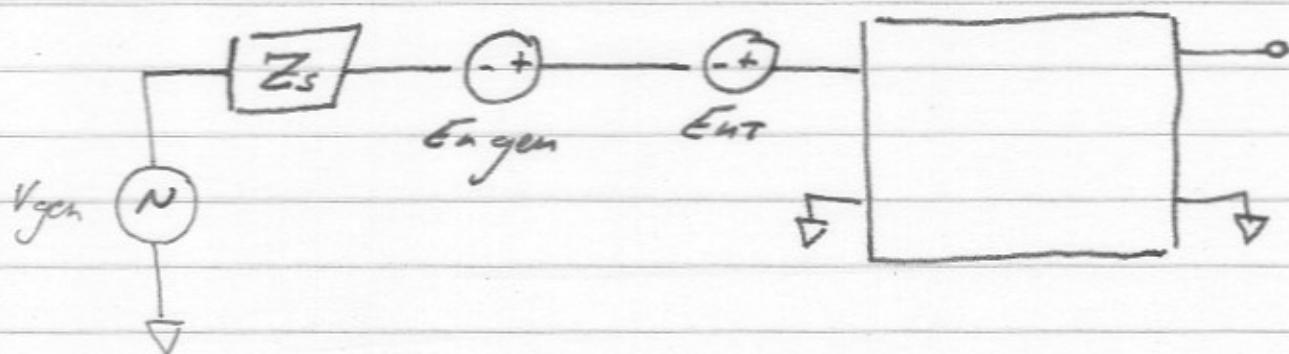
I_n : equivalent open-circuit input noise current

E_n : equivalent short-circuit input noise voltage.

I_n & E_n are generally correlated.

(5)

(c) For a specific Ngi generator impedance:



$$\frac{d}{dt} \langle E_{out} E_{out}^* \rangle = \frac{d}{dt} \langle E_{gen} E_{gen}^* \rangle$$

$$+ \|Z_s\|^2 \cdot \frac{d}{dt} \langle I_n I_n^* \rangle$$

$$+ 2 \operatorname{Re} \left\{ Z_s^* \frac{d}{dt} \langle E_n E_n^* \rangle \right\}$$

- derived from $E_{out} = E_n + Z_s I_n$.

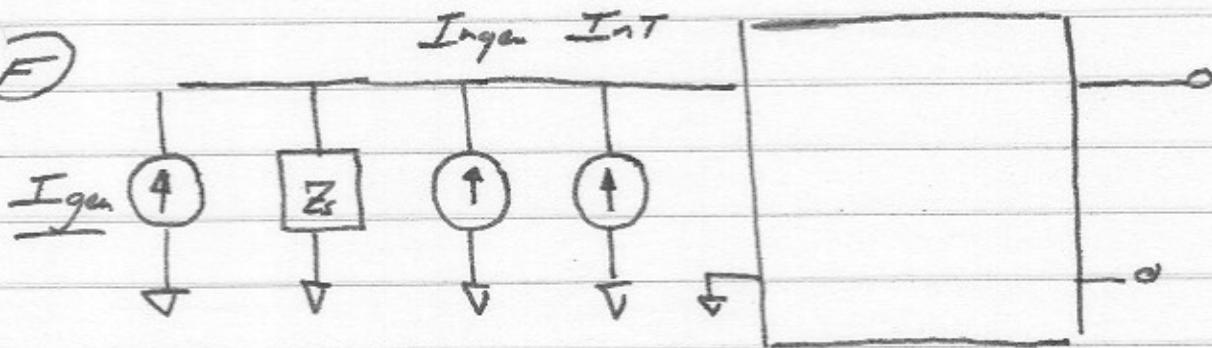
- E_{gen} is the generator noise;

$$\frac{d}{dt} \langle E_{gen} E_{gen}^* \rangle \neq 4kT \operatorname{Re}\{Z_s\}$$

unless the generator is a simple resistive network !!!

(6)

(F)



$$\frac{d}{dt} \langle I_{\text{Int}} I_{\text{Int}}^* \rangle = \frac{d}{dt} \langle I_n I_n^* \rangle$$

$$+ \left| \frac{1}{Z_S} \right|^2 \cdot \frac{d}{dt} \langle E_n E_n^* \rangle$$

$$+ 2 \operatorname{Re} \left[\frac{1}{Z_S} * \frac{d}{dt} \langle I_n E_n^* \rangle \right]$$

- derived from $\text{Eff Int} = I_n + E_n / Z_S$

- I_{gen} is generator noise,

again not necessarily with $P_{\text{av}} = kT$.

(7)

G

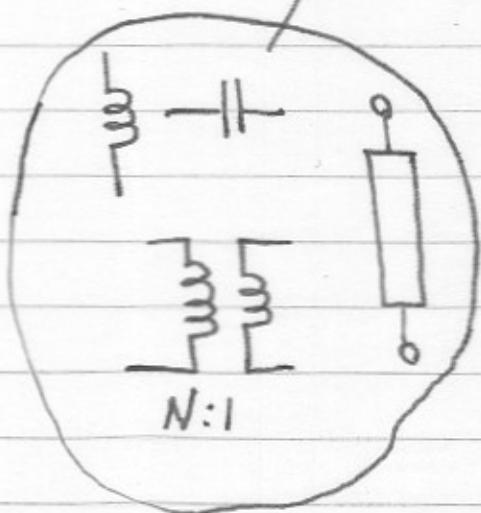
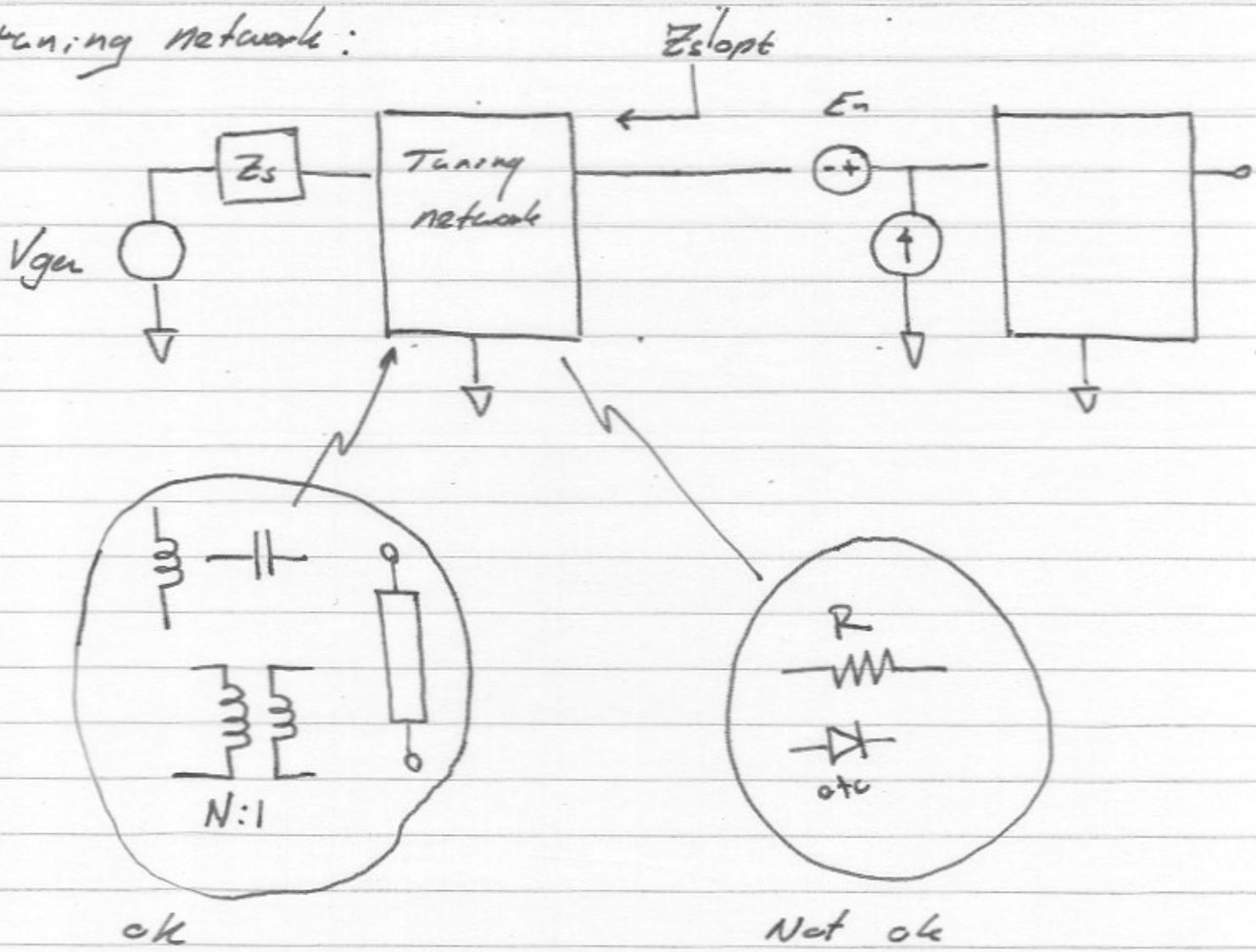
From either E or F, if we want to calculate noise figures, we can

$$F = 1 + \frac{\frac{\partial}{\partial f} \langle V_n V_n^* \rangle + Z_g Z_g^* \frac{\partial}{\partial f} \langle I_n I_n^* \rangle + 2R_e \left[Z_g^* \frac{\partial}{\partial f} \langle E_n I_n^* \rangle \right]}{4kT \text{ Re}[Z_g]}$$

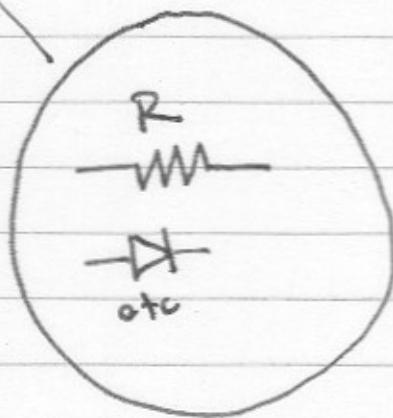
and noise temperature:

$$T_{eq} = \frac{\frac{\partial}{\partial f} \langle V_n V_n^* \rangle + Z_g Z_g^* \frac{\partial}{\partial f} \langle I_n I_n^* \rangle + 2R_e \left[Z_g^* \frac{\partial}{\partial f} \langle E_n I_n^* \rangle \right]}{4 \cdot k \cdot R_e [Z_g]}$$

(H) We were able to show that if we match $\sqrt{f_0}$ to the generator impedance using a Lossless (e.g. Noiseless) input tuning network:



ok



Not ok

- absorbs power
- generates noise.

(9)

... Then the Minimum Noise figure is:

$$F = 1 +$$

$$\frac{1}{4KT} \left\{ 2 \cdot \sqrt{\frac{2}{2f} \langle V_n V_n^* \rangle \cdot \frac{\partial}{\partial f} \langle I_n I_n^* \rangle - \left(\text{Im} \left(\frac{\partial}{\partial f} \langle V_n I_n^* \rangle \right) \right)^2} \right.$$

$$\left. + 2 \cdot \text{Re} \left[\frac{2}{2f} \langle V I^* \rangle \right] \right\}$$

where

$$Z_{opt} = R_{opt} + j X_{opt}$$

$$R_{opt} = \frac{\frac{2}{2f} \langle V_n V_n^* \rangle}{\frac{\partial}{\partial f} \langle I_n I_n^* \rangle} - \left[\frac{\text{Im} \left(\frac{\partial}{\partial f} \langle V_n I_n^* \rangle \right)}{\frac{\partial}{\partial f} \langle I_n I_n^* \rangle} \right]^2$$

and

$$X_{opt} = - \frac{\text{Im} \left[\frac{2}{2f} \langle V_n I_n^* \rangle \right]}{\frac{\partial}{\partial f} \langle I_n I_n^* \rangle}$$

Pause, and Make 2 observations:

1) Whether we choose to work with

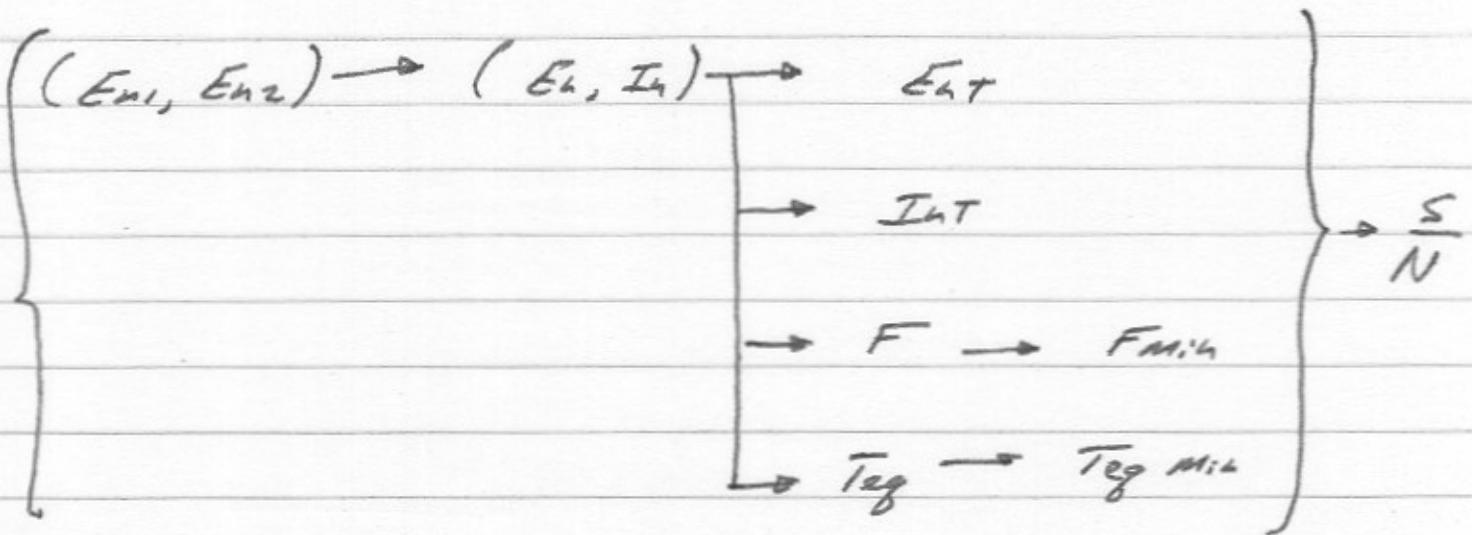
$\langle En, In \rangle$, Eat, Int, or Forteg is very much a matter of choice, based upon the relative convenience of each tool & upon the traditions of the field involved.

ultimately our goal is to find a

Signal to Noise Ratio and we can work

towards this using Eat, Int, F, Teg, etc at our choice.

2) I have presented the development of ...

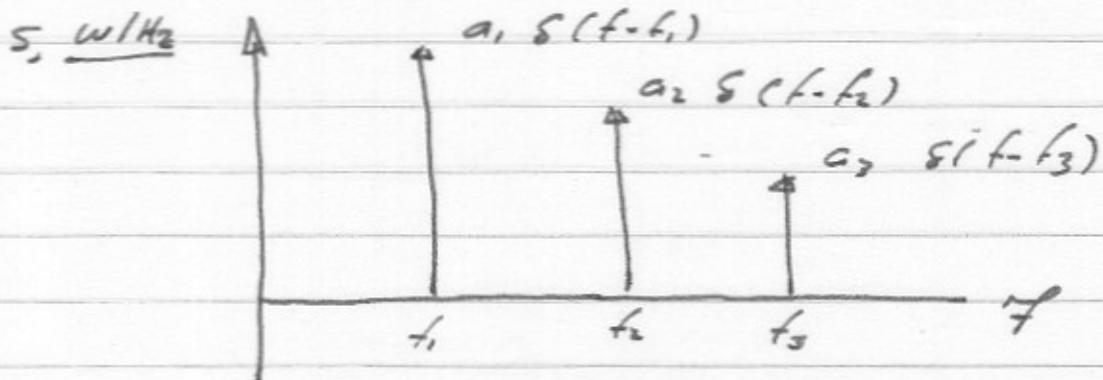


... as a sequence of steps. This is how
a computer would do it. If you are
writing computer code, this is how you should
do it, too.

If you are doing hand analysis, you can
actually work in one step to the particular
answer you require.

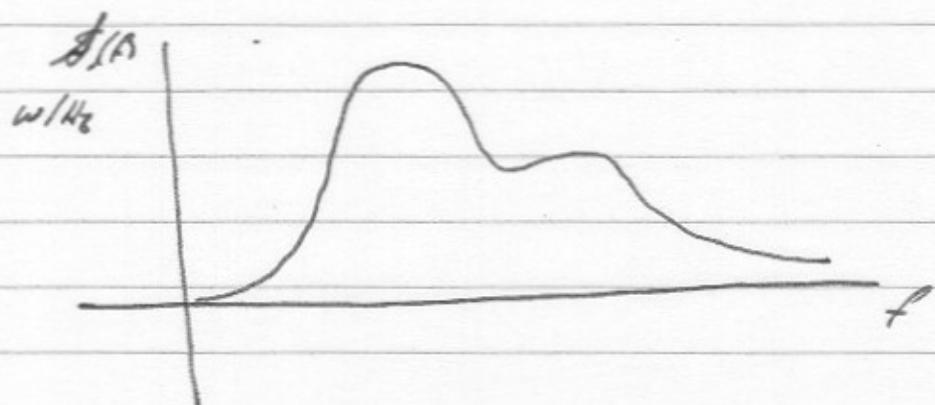
As I just mentioned, ultimately we are interested in a signal / noise ratio

Signals may be discrete (deterministic), with an impulsive power spectrum



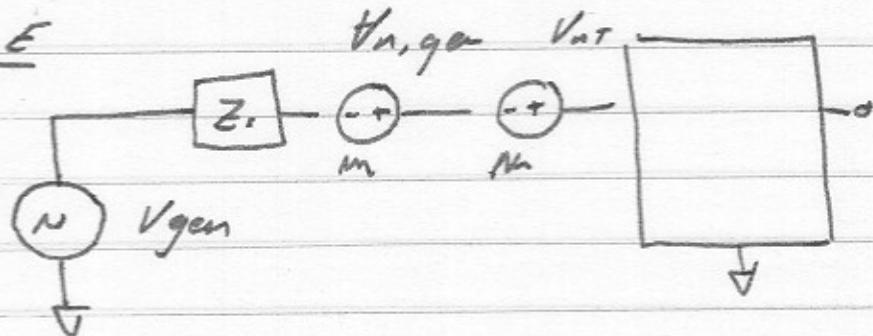
so each line has units, not of watts/Hz , but of watts.

often we are dealing with signals carrying information or modulation, which are therefore themselves random processes, and the signal has a power spectrum in W/Hz

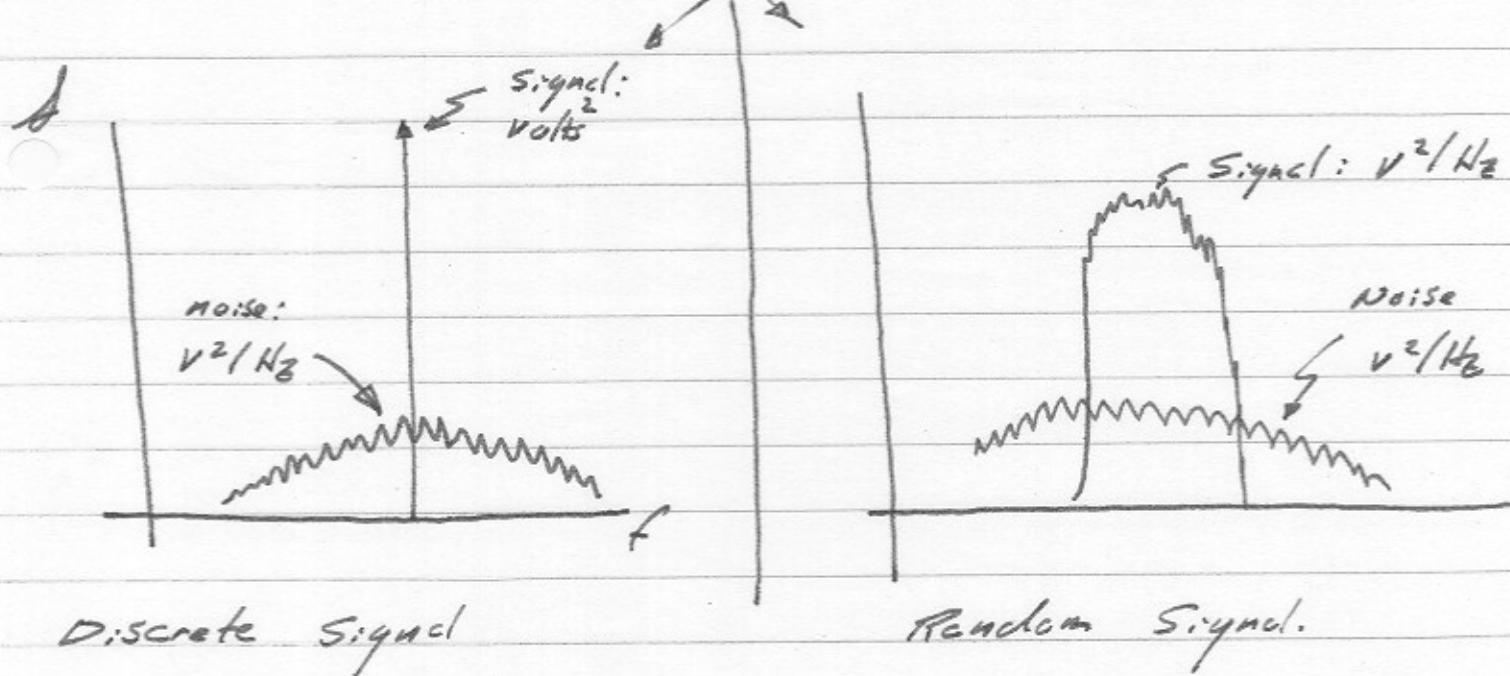


Total voltage method

Case E



$$\frac{S}{N} = \frac{\frac{d}{dt} \langle V_{gen} V_{gen}^* \rangle}{\frac{d}{dt} \langle V_{gen} V_{gen}^* \rangle + \frac{d}{dt} \langle V_{AT} V_{AT}^* \rangle}$$

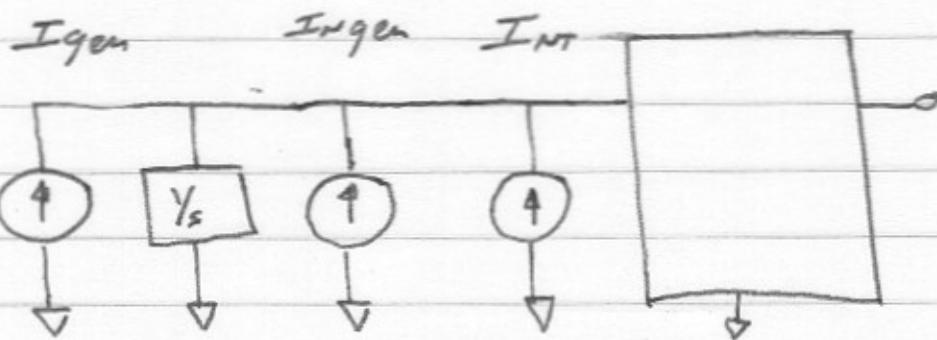


S/N: dB (1Hz)

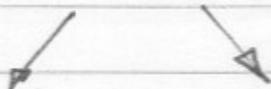
SIN dB.

Total Current Method

Case F



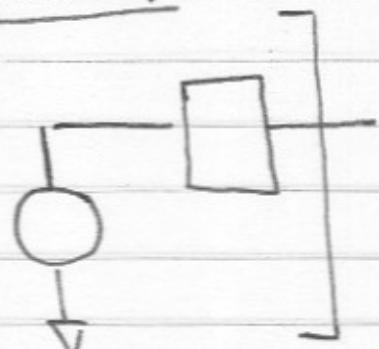
$$\frac{S}{N} = \frac{\frac{2}{\Delta f} \langle I_{gen} I_{gen}^* \rangle}{\frac{2}{\Delta f} \langle I_{int} I_{int}^* \rangle + \frac{2}{\Delta f} \langle I_{gen} I_{gen}^* \rangle}$$



(some pictures)

~~total~~ Power Method

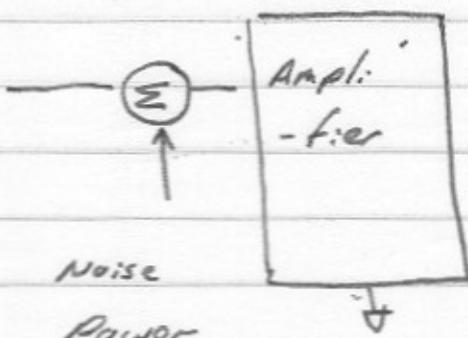
Case G



generator:

$$\frac{d}{df} \langle P_{av, \text{signal}} \rangle$$

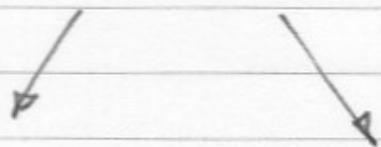
$$\frac{d}{df} \left\langle P_{av, \text{noise}} \right\rangle_{\text{gen}}$$



adds power available

$$KT(F-1)$$

$$\frac{S}{N} = \frac{\frac{d}{df} \langle P_{av, \text{signal}} \rangle}{\frac{d}{df} \left\langle P_{av, \text{noise}} \right\rangle_{\text{gen}} + KT(F-1)}$$



(Same pictures)

Temperature Method

Case G (5)

$$\frac{S}{N} = \frac{\frac{1}{K} \frac{\partial}{\partial T} \langle P_{av}, \text{Signal} \rangle}{T_{\text{generator}} + T_{\text{noise, amplifier}}}$$

... or ...

$$\frac{S}{N} = \frac{\frac{1}{K} \frac{\partial}{\partial T} \langle P_{av}, \text{Signal} \rangle}{T_{\text{generator}} + T_{\text{noise, amplifier}}}$$

"signal temperature"

Simply: There are many roads to Rome.

We can work with noise voltages, currents, powers,
or equivalent temperatures, but our goal is finally
to find a Signal / Noise ratio.

Preferred method a matter of convenience & tradition

The traditions are as follows:

Radio receivers / Radar / etc, primarily terrestrial

Impedance matching easy. Powers \propto relevant quantities. Antenna temperatures near 300°K.

→ Power Method / Noise figure.

Fiber optic receivers - Electronic kind

Here very broadband, so matching impossible over bandwidth.

^{Available}
Noise signal power, etc, \propto not very useful idea.

Photodiode approximately an infinite impedance, so signal power not defined.

→ input referred noise current.

Similar: Geiger Counter, etc, for

nuclear instrumentation.

Low-Frequency Instrumentation

usually broadband \rightarrow no matching

\rightarrow signal power concepts generally unhelpful.

Traditional method of looking at signal voltages

using an oscilloscope \rightarrow noise voltage method.

Radio astronomy & satellite radio systems

See radio comments above. But antenna noise

temperature between $\sim 3 - 200\text{ K}$, not 300 K . Equivalent

Temperature method used.